Silvia Armini

List of Publications by Year in descending order

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331538 377752 1,429 74 21 34 citations h-index g-index papers 74 74 74 1369 docs citations times ranked citing authors all docs

#	Article	IF	CITATIONS
1	The role of atomic oxygen in the decomposition of self-assembled monolayers during area-selective atomic layer deposition. Applied Surface Science, 2022, 586, 152679.	3.1	4
2	Understanding Selectivity Loss Mechanisms in Selective Material Deposition by Area Deactivation on 10 nm Cu/SiO ₂ Patterns. ACS Applied Electronic Materials, 2022, 4, 1703-1714.	2.0	9
3	Understanding the impact of Cu surface pre-treatment on Octadecanethiol-derived self-assembled monolayer as a mask for area-selective deposition. Applied Surface Science, 2021, 540, 148307.	3.1	11
4	Enabling bottom-up nanoelectronics fabrication by selective sol–gel dielectric-on-dielectric deposition. Materials Science and Engineering B: Solid-State Materials for Advanced Technology, 2021, 263, 114808.	1.7	1
5	Nanomechanical Characterization of Organic Surface Passivation Films on 50 nm Patterns during Area-Selective Deposition. ACS Applied Electronic Materials, 2021, 3, 2622-2630.	2.0	7
6	Cyclic Plasma Halogenation of Amorphous Carbon for Defect-Free Area-Selective Atomic Layer Deposition of Titanium Oxide. ACS Applied Materials & Samp; Interfaces, 2021, 13, 32381-32392.	4.0	8
7	Area-Selective ALD of Ru on Nanometer-Scale Cu Lines through Dimerization of Amino-Functionalized Alkoxy Silane Passivation Films. ACS Applied Materials & Samp; Interfaces, 2020, 12, 4678-4688.	4.0	25
8	Area-selective Ru ALD by amorphous carbon modification using H plasma: from atomistic modeling to full wafer process integration. Materials Advances, 2020, 1, 3049-3057.	2.6	6
9	Area-Selective Atomic Layer Deposition of TiN Using Trimethoxy(octadecyl)silane as a Passivation Layer. Langmuir, 2020, 36, 13144-13154.	1.6	7
10	Structural Phases of Alkanethiolate Self-Assembled Monolayers (C _{1–12}) on Cu[100] by Density Functional Theory. Journal of Physical Chemistry C, 2020, 124, 3802-3811.	1.5	4
11	Plasma halogenated a-C:H as growth inhibiting layer for ASD of titanium oxide. , 2020, , .		2
12	Vapor-deposited zeolitic imidazolate frameworks as gap-filling ultra-low-k dielectrics. Nature Communications, 2019, 10, 3729.	5.8	106
13	Area-Selective Deposition by a Combination of Organic Film Passivation and Atomic Layer Deposition. ECS Transactions, 2019, 92, 25-32.	0.3	7
14	Self-focusing SIMS: A metrology solution to area selective deposition. Applied Surface Science, 2019, 476, 594-599.	3.1	10
15	Rethinking surface reactions in nanoscale dry processes toward atomic precision and beyond: a physics and chemistry perspective. Japanese Journal of Applied Physics, 2019, 58, SE0801.	0.8	9
16	Selective electroless deposition of cobalt using amino-terminated SAMs. Journal of Materials Chemistry C, 2019, 7, 4392-4402.	2.7	21
17	Metal barrier induced damage in self-assembly based organosilica low-k dielectrics and its reduction by organic template residues. Applied Surface Science, 2019, 485, 170-178.	3.1	7
18	Area selective grafting of siloxane molecules on low-k dielectric with respect to copper surface. Applied Surface Science, 2019, 476, 317-324.	3.1	9

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19	High sensitivity Rutherford backscattering spectrometry using multidetector digital pulse processing. Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films, 2018, 36, 02D407.	0.9	9
20	Template-dependent hydrophobicity in mesoporous organosilica films. Microporous and Mesoporous Materials, 2018, 259, 111-115.	2.2	7
21	On the use of (3-trimethoxysilylpropyl)diethylenetriamine self-assembled monolayers as seed layers for the growth of Mn based copper diffusion barrier layers. Applied Surface Science, 2018, 427, 260-266.	3.1	26
22	Vapor-deposited octadecanethiol masking layer on copper to enable area selective Hf3N4 atomic layer deposition on dielectrics studied by in situ spectroscopic ellipsometry. Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films, 2018, 36, 031605.	0.9	44
23	Tuning the Properties of Periodic Mesoporous Organosilica Films for Lowâ€k Application by Gemini Surfactants. ChemPhysChem, 2018, 19, 2295-2298.	1.0	2
24	Nucleation and adhesion of ultra-thin copper films on amino-terminated self-assembled monolayers. Applied Surface Science, 2018, 462, 38-47.	3.1	18
25	Impact of organic linking and terminal groups on the mechanical properties of self-assembly based low-k dielectrics. Applied Physics Letters, 2017, 111, 161906.	1.5	6
26	Selective Ru ALD as a Catalyst for Sub-Seven-Nanometer Bottom-Up Metal Interconnects. ACS Applied Materials & Samp; Interfaces, 2017, 9, 31031-31041.	4.0	47
27	Periodic Mesoporous Organosilica Films with a Tunable Steadyâ€State Mesophase. ChemPhysChem, 2017, 18, 2846-2849.	1.0	1
28	On the mechanical and electrical properties of self-assembly-based organosilicate porous films. Journal of Materials Chemistry C, 2017, 5, 8599-8607.	2.7	7
29	Optimization and upscaling of spin coating with organosilane monolayers for low-k pore sealing. Microelectronic Engineering, 2017, 167, 32-36.	1.1	6
30	Surface-confined activation of ultra low-k dielectrics in CO2 plasma. Applied Physics Letters, 2016, 108,	1.5	11
31	Sacrificial Self-Assembled Monolayers for the Passivation of GaAs (100) Surfaces and Interfaces. Chemistry of Materials, 2016, 28, 5689-5701.	3.2	20
32	Application of Self-Assembled Monolayers to the Electroless Metallization of High Aspect Ratio Vias for Microelectronics. Journal of Electronic Materials, 2016, 45, 5449-5455.	1.0	8
33	Surface sealing using self-assembled monolayers and its effect on metal diffusion in porous low- k dielectrics studied using monoenergetic positron beams. Applied Surface Science, 2016, 368, 272-276.	3.1	22
34	UV cure of oxycarbosilane low-k films. Microelectronic Engineering, 2016, 156, 103-107.	1.1	8
35	Stuffing-enabled surface confinement of silanes used as sealing agents on CF4 plasma-exposed 2.0 p-OSG films. Microelectronic Engineering, 2015, 137, 70-74.	1.1	7
36	Partial Wetting of Aqueous Solutions on High Aspect Ratio Nanopillars with Hydrophilic Surface Finish. ECS Journal of Solid State Science and Technology, 2014, 3, N3095-N3100.	0.9	14

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37	Nucleation Kinetics of Electroless Cu Deposition on Ruthenium Using Glyoxylic Acid as a Reducing Agent. Journal of the Electrochemical Society, 2014, 161, D768-D774.	1.3	14
38	Pore sealing of k 2.0 dielectrics assisted by self-assembled monolayers deposited from vapor phase. Microelectronic Engineering, 2014, 120, 240-245.	1.1	24
39	Capturing Wetting States in Nanopatterned Silicon. ACS Nano, 2014, 8, 885-893.	7.3	55
40	Impact of Plasma Pretreatment and Pore Size on the Sealing of Ultra-Low- <i>k</i> Dielectrics by Self-Assembled Monolayers. Langmuir, 2014, 30, 3832-3844.	1.6	28
41	Wafer Scale Copper Direct Plating on Thin PVD RuTa Layers: A Route to Enable Filling 30 nm Features and Below?. Journal of the Electrochemical Society, 2014, 161, D564-D570.	1.3	4
42	Electrical properties of amino SAM layers studied with conductive AFM. European Polymer Journal, 2013, 49, 1952-1956.	2.6	7
43	Direct Copper Electrochemical Deposition on Ru-Based Substrates for Advanced Interconnects Target 30 nm and $\hat{A}\frac{1}{2}$ Pitch Lines: From Coupon to Full-Wafer Experiments. Journal of the Electrochemical Society, 2013, 160, D89-D94.	1.3	15
44	Electroless Cu deposition on atomic layer deposited Ru as novel seed formation process in through-Si vias. Electrochimica Acta, 2013, 100, 203-211.	2.6	42
45	Selective self-assembled monolayer coating to enable Cu-to-Cu connection in dual damascene vias. Microelectronic Engineering, 2013, 106, 76-80.	1.1	9
46	(Invited) Wetting Behavior of Aqueous Solutions on High Aspect Ratio Nanopillars with Hydrophilic Surface Finish. ECS Transactions, 2013, 58, 171-182.	0.3	4
47	The Effects of Plasma Treatments and Subsequent Atomic Layer Deposition on the Pore Structure of a $k=2.0\text{Low-}k$ Material. ECS Journal of Solid State Science and Technology, 2013, 2, N103-N109.	0.9	7
48	Electroless Copper Bath Stability Monitoring with UV-VIS Spectroscopy, pH, and Mixed Potential Measurements. Journal of the Electrochemical Society, 2012, 159, D437-D441.	1.3	22
49	Pore Sealing of Porous Ultralow-k Dielectrics by Self-Assembled Monolayers Combined with Atomic Layer Deposition. ECS Solid State Letters, 2012, 1, P42-P44.	1.4	23
50	Numerical analysis of zeptogram/Hz-level mass responsivity for in-plane resonant nano-electro-mechanical sensors. Microelectronic Engineering, 2011, 88, 2879-2884.	1.1	7
51	Integration challenges of copper Through Silicon Via (TSV) metallization for 3D-stacked IC integration. Microelectronic Engineering, 2011, 88, 745-748.	1.1	66
52	Copper plating for 3D interconnects. Microelectronic Engineering, 2011, 88, 701-704.	1.1	77
53	Temperature insensitive conductance detection with surface-functionalised silicon nanowire sensors. Microelectronic Engineering, 2011, 88, 1753-1756.	1.1	3
54	Impact of "terminal effect―on Cu electrochemical deposition: Filling capability for different metallization options. Microelectronic Engineering, 2011, 88, 754-759.	1.1	22

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55	Evaluation of Metallization Options for Advanced Cu Interconnects Application. ECS Transactions, 2011, 34, 515-521.	0.3	9
56	Cu Electrodeposition on Resistive Substrates in Alkaline Chemistry: Effect of Current Density and Wafer RPM. Journal of the Electrochemical Society, 2011, 158, D390.	1.3	20
57	Bottomâ€Up Engineering of Subnanometer Copper Diffusion Barriers Using NH ₂ â€Derived Selfâ€Assembled Monolayers. Advanced Functional Materials, 2010, 20, 1125-1131.	7.8	53
58	Controlling Scratching in Cu Chemical Mechanical Planarization. Journal of the Electrochemical Society, 2009, 156, H528.	1.3	10
59	Electroless Cu Deposition on Self-assembled Monolayer Alternative Barriers. Materials Research Society Symposia Proceedings, 2009, 1156, 1.	0.1	3
60	Copper CMP with Composite Polymer Core–Silica Shell Abrasives: A Defectivity Study. Journal of the Electrochemical Society, 2009, 156, H18.	1.3	34
61	Determination of the Binding of Non-Cross-Linked and Cross-Linked Gels to Living Cells by Atomic Force Microscopy. Langmuir, 2009, 25, 6977-6984.	1.6	7
62	Prediction of scratch generation in chemical mechanical planarization. CIRP Annals - Manufacturing Technology, 2008, 57, 559-562.	1.7	65
63	Copper CMP with Composite Polymer Core - Silica Shell Abrasives: A Defectivity Study. Materials Research Society Symposia Proceedings, 2008, 1079, 1.	0.1	2
64	Composite Polymer Core–Silica Shell Abrasives: The Effect of the Shape of the Silica Particles on Oxide CMP. Journal of the Electrochemical Society, 2008, 155, H401.	1.3	24
65	Composite Polymer Core–Ceria Shell Abrasive Particles during Oxide CMP: A Defectivity Study. Journal of the Electrochemical Society, 2008, 155, H653.	1.3	77
66	Engineering Polymer Core–Silica Shell Size in the Composite Abrasives for CMP Applications. Electrochemical and Solid-State Letters, 2008, 11, H280.	2.2	17
67	Mixed Organic/Inorganic Abrasive Particles during Oxide CMP. Electrochemical and Solid-State Letters, 2008, 11, H197.	2.2	5
68	Interaction Forces Between a Glass Surface and Ceria-Modified PMMA-Based Abrasives for CMP Measured by Colloidal Probe AFM. Journal of the Electrochemical Society, 2008, 155, H218.	1.3	11
69	Interaction Forces Between a Glass Surface and Silica-Modified PMMA-Based Abrasives for CMP Measured by Colloidal AFM. Electrochemical and Solid-State Letters, 2007, 10, H74.	2.2	10
70	Composite Polymer-Core Silica-Shell Abrasive Particles during Oxide CMP. Journal of the Electrochemical Society, 2007, 154, H667.	1.3	53
71	Composite Polymer Core–Silica Shell Abrasives. Electrochemical and Solid-State Letters, 2007, 10, H243.	2.2	13
72	Composite polymer core – ceria shell abrasive particles during silicon oxide CMP. Materials Research Society Symposia Proceedings, 2007, 991, 1.	0.1	1

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73	Nanoscale Indentation of Polymer and Composite Polymerâ 'Silica Coreâ 'Shell Submicrometer Particles by Atomic Force Microscopy. Langmuir, 2007, 23, 2007-2014.	1.6	57
74	Size Shrinkage of Methacrylate-based Terpolymer Latexes Synthesized by Free Radical Polymerization: Kinetics and Influence of Main Reaction Parameters. Polymer Journal, 2006, 38, 786-798.	1.3	13